



Cite this: *RSC Adv.*, 2019, 9, 3550

CrO₂-based heterostructure and magnetic tunnel junction: perfect spin filtering effect, spin diode effect and high tunnel magnetoresistance

Jiangchao Han,^a Jimei Shen^b and Guoying Gao *^{ac}

Half-metallic ferromagnetic CrO₂ has attracted much interest due to its 100% spin polarization and high Curie temperature. CrO₂ films have been fabricated on a TiO₂ (100) substrate. However, there have been no reports on the spin transport properties of devices based on a CrO₂ electrode and TiO₂ barrier. In this work, we use first-principles calculations combined with a nonequilibrium Green's function method to investigate the bias-voltage-dependent spin transport properties for the CrO₂/TiO₂ (100) heterostructure and the CrO₂/TiO₂/CrO₂ (100) magnetic tunnel junction (MTJ). Our results reveal the excellent spin filtering effect and spin diode effect in the heterostructure as well as the high tunnel magnetoresistance ratio (up to 4.48 × 10¹⁴%) in the MTJ, which indicate potential spintronic applications. The origins of these perfect spin transport characteristics are discussed in terms of the calculated spin-dependent electrode band structures, the spin-dependent transmission spectra and semiconductor theory.

Received 30th September 2018
 Accepted 17th January 2019

DOI: 10.1039/c8ra08107g

rsc.li/rsc-advances

1. Introduction

Spintronic devices, which use electronic spin or both electronic charge and spin to increase the data processing speed and decrease electric power consumption compared to conventional semiconductor devices, have attracted more and more research interest.¹ One of the keys to high-performance spintronic devices is high spin injection efficiency from a magnetic material to a semiconductor, and thus high-spin-polarized materials are desired.² Half-metallic magnets,³ which possess 100% spin polarization of electrons due to the fact that one of the two spin channels is metallic and the other has semiconductor or insulator characteristics, have been seen as promising candidates for high-spin-polarized materials and received extensive experimental and theoretical attention.^{4–8}

Rutile CrO₂ is one of the most famous spintronic materials due to its nearly 100% spin polarization and high Curie temperature (394 K).^{9–12} Rutile TiO₂ is a semiconductor with the same crystal structure and comparable lattice constant with CrO₂.¹³ So, TiO₂ was usually used as the substrate to grow the CrO₂ films. Bulk half-metallic ferromagnetic CrO₂ is a metastable oxide phase that degrades at a high temperature (above 400 K) and atmospheric pressure into the thermodynamically more stable antiferromagnetic insulator Cr₂O₃ phase,¹⁴ and there are more or less Cr₂O₃ at the surface of CrO₂,^{15–17} however,

with the improvement of experimental technology and the control of growth condition, single crystal CrO₂ films with a better crystalline quality and different orientations have been successfully grown on the TiO₂ (100), TiO₂ (001) and TiO₂ (110) substrates by the chemical vapor deposition technique.^{17–20}

For the spintronic applications, there have been some studies on electronic transport properties based on CrO₂ electrode.^{21–26} Meena and Choudhary^{21–25} systemically investigated the spin transport properties for some magnetic tunnel junctions (MTJs) based on CrO₂ electrode and different barriers such as the graphene and the carbon nanotube, and large tunneling magnetoresistance (TMR) ratios were predicted. Leo *et al.*²⁶ experimentally studied the TMR in the MTJ of CrO₂/MgO/CoFe (100), and revealed that the TMR sign can be reversed simply by subtle modifications to the CrO₂/MgO interface. In addition, some MTJs, where TiO₂ as the barrier and other magnetic materials instead of CrO₂ as the electrodes, have also been explored.^{27–30} These studies indicated that the large TMR ratio is related to the electrode with high spin polarization and the property of tunnel barrier in the MTJ. As far as we know, however, there is no report on the spin transport properties of the MTJ of CrO₂/TiO₂/CrO₂, considering the facile growth of the CrO₂ films on the TiO₂ (100) substrate,^{17,20} it is meaningful to explore the potential spintronic applications for the CrO₂/TiO₂ (100) heterostructure and the CrO₂/TiO₂/CrO₂ (100) MTJ. In the present work, our calculations based on the first-principles combined with the nonequilibrium Green's function method reveal that the CrO₂/TiO₂ (100) heterostructure behaves obvious spin diode effect and spin filtering effect, and the CrO₂/TiO₂/CrO₂ (100) MTJ has a high TMR ratio (up to 4.48 × 10¹⁴%).

^aSchool of Physics, Huazhong University of Science and Technology, Wuhan 430074, China. E-mail: guoying_gao@mail.hust.edu.cn

^bNanjing Normal University Taizhou College, Taizhou 225300, China

^cWuhan National High Magnetic Field Center, Huazhong University of Science and Technology, Wuhan 430074, China



These results could be helpful for the experimental realization of CrO₂-based spintronic devices.

2. Computational details

Rutile CrO₂ belongs to the tetragonal structure (*P4₂/mnm*) with lattice parameters $a = b = 4.421 \text{ \AA}$ and $c = 2.916 \text{ \AA}$,³¹ while isostructural TiO₂ has the lattice parameters $a = b = 4.594 \text{ \AA}$ and $c = 2.958 \text{ \AA}$.³² Considering the experimental growth of CrO₂ (100) films on the TiO₂ (100) substrates and the small lattice mismatch along (100) direction (1.72%), we construct the CrO₂/TiO₂ (100) heterostructure and the CrO₂/TiO₂/CrO₂ (100) MTJ based on the TiO₂ lattice constant. As shown in Fig. 1, both models of the two devices are divided into three parts: the left electrode, the scattering region, and the right electrode. Note that there are four possible contacts for the interface between CrO₂ and TiO₂: Cr–O interface (type-I), Cr–Ti interface (type-II), O–Ti interface (type-III) and O–O interface (type-IV). We relax the four interfaces and the calculated total energies are -8752.1461 , -8750.3011 , -8751.7887 and -8749.9607 eV per cell for the four interfaces, respectively, which indicate that the type-I configuration is most stable relatively. So, in our present work, we focus on the type-I structure for the transport properties of the heterostructure and the MTJ.

Our calculations are performed by the Atomistix ToolKit (ATK) package, which combines the nonequilibrium Green's function (NEGF) and the density functional theory (DFT).^{33,34} The generalized gradient approximation (GGA) with the Perdew–Burke–Ernzerhof (PBE) form is adopted for the electronic exchange–correlation functional.³⁵ Before calculating the transport properties, the interface relaxation is carried out until the force on each atom is less than 0.01 eV \AA^{-1} . The electron wave function of the linear combination of atomic orbitals (LCAO) is cut off at a kinetic energy of 2041 eV, and the Brillouin zone of the unit cell is sampled by using a $6 \times 4 \times 1$ *k*-point grid. In the calculations of transport properties, the Monkhorst–Pack *k*-meshes of both devices are $6 \times 4 \times 100$, the integration grid of the current calculation is 10×10 , and the self-consistent calculations are limited to 2.7×10^{-4} eV tolerance. All these parameters are tested to be sufficient to obtain accurate results, and the present method has been successfully used in our

previous works on spin transport properties of magnetic heterostructures and MTJs.^{36,37} The spin-dependent current is calculated by the Landauer–Buttiker formula:

$$I^{\uparrow(\downarrow)} = \frac{e}{h} \int_{-\infty}^{\infty} \{T^{\uparrow(\downarrow)}(E, V_b)[f_L(E - \mu_L) - f_R(E - \mu_R)]\} dE, \quad (1)$$

where $f_{L/R}(E - \mu_{L/R})$ is the Fermi–Dirac distribution for the left (right) electrode, and $\mu_{L/R} = E_F \pm eV/2$ is the corresponding electrochemical potential. $T^{\uparrow(\downarrow)}(E, V_b)$ is the spin-dependent transmission coefficient,

$$T^{\uparrow(\downarrow)}(E, V_b) = \text{Tr}[\Gamma_L G^R \Gamma_R G^A]^{\uparrow(\downarrow)}, \quad (2)$$

where $G^{R(A)}$ is the retarded (advanced) Green's function of the central region, and $\Gamma_{L(R)}$ is the coupling matrix of the left (right) electrode.

3. Results and discussion

3.1. Spin diode and spin filtering effects in the CrO₂/TiO₂ heterostructure

We first study the spin transport properties of the CrO₂/TiO₂ (100) heterostructure. The spin-resolved current is calculated under the bias voltage range from -1 V to 1 V , as shown in Fig. 2. It is clear that the spin-down current is absolutely inhibited. For the spin-up current, the value is close to zero when the applied voltage is positive. When the negative voltage is applied, however, the spin-up current rapidly increases with the increasing negative bias voltage. Hence the heterostructure exhibits perfect spin diode effect in the spin-up channel and successfully filters out the spin-down current. The rectification ratio,³⁸ $\text{RR}(V) = |I(-V)/I(V)|$, is usually used to evaluate the diode performance, and a large rectification ratio means a good diode effect. Fig. 2 indicates that the largest RR value in the spin-up channel reaches 7.8×10^5 at 0.75 V. Such a large RR indicates excellent unidirectional conductivity, making CrO₂ a promising candidate for spin diode application. In addition, we calculate the efficiency of the spin filtering by $\eta = [(I_{\uparrow} - I_{\downarrow})/(I_{\uparrow} + I_{\downarrow})] \times 100\%$, where I_{\uparrow} and I_{\downarrow} are the spin-up and spin-down currents, respectively.³⁹ As shown in Fig. 2(b), the efficiency of the spin filtering is almost complete.

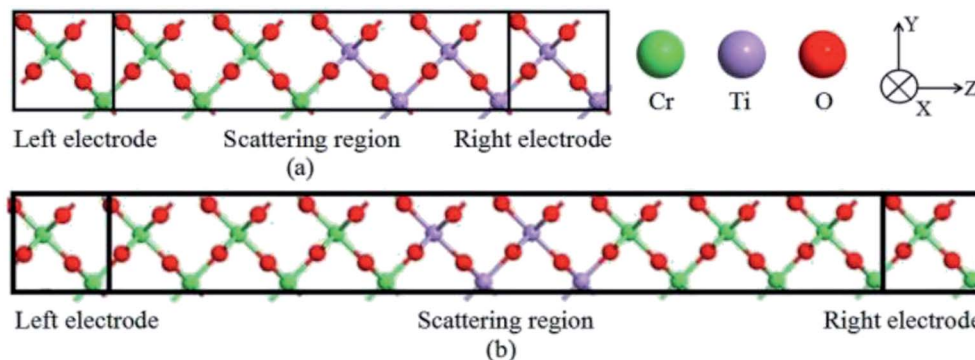


Fig. 1 Schematic illustrations of the devices of the CrO₂/TiO₂ (100) heterostructure (a) and the CrO₂/TiO₂/CrO₂ (100) magnetic tunnel junction (MTJ) (b). The *z* direction is the transmission direction.



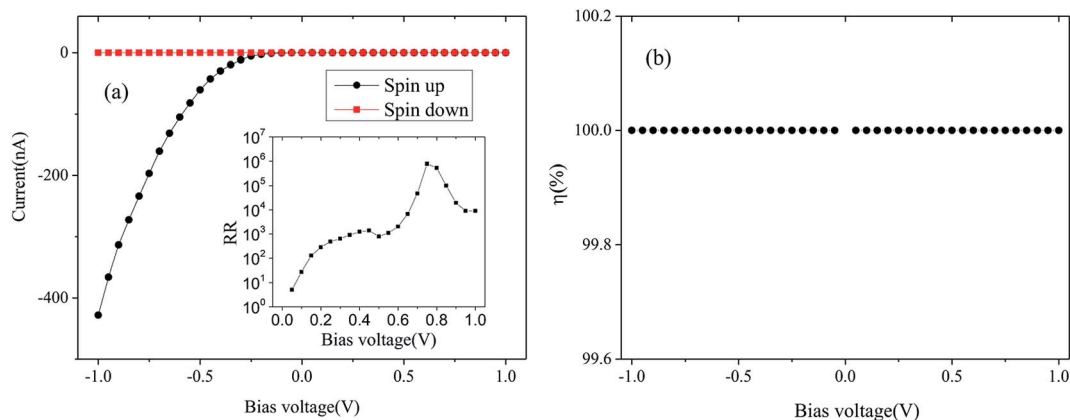


Fig. 2 (a) The spin-dependent current-bias voltage curve of the $\text{CrO}_2/\text{TiO}_2$ (100) heterostructure. The inset is the rectification ratio (RR) in spin-up channel with the change of bias voltage. (b) The spin-filtering efficiency η (in %) versus bias voltage.

We further present in Fig. 3 the calculated spin-dependent band structures of the left electrode CrO_2 (100) and the right electrode TiO_2 (100) in order to explain the spin-dependent current-voltage curve. One can see from Fig. 3 that the left electrode CrO_2 is a typical half-metal: a metallic characteristic in the spin-up channel and the Fermi level falls in a large energy gap in the spin-down channel. The top of the spin-down valence bands is about 0.91 eV below the Fermi level at the (000) k point, and the bottom of the spin-down conduction bands is about 3.64 eV above the Fermi level at the same k point. For the right electrode TiO_2 (100), the top of the valence bands is tangent to the Fermi level and there is a wide band gap above the Fermi level. According to the electrochemical potentials of the left and right electrodes, $\mu_{L/R} = E_F \pm (1/2)eV_b$, the Fermi level of the left electrode (right electrode) will move down (up) $(1/2)eV_b$ when

a positive bias voltage V_b is applied. Therefore, in the applied voltage range from 0 V to 1 V, the spin-up valence bands of the left electrode cross the Fermi level and the transmission channel is generated in the spin-up channel of the left electrode. At the same time, the Fermi level of the right electrode falls in the semiconductor gap. Such a big gap could not motivate the right electrode to produce transmission channel. Hence, either in the spin-up or spin-down state, the Bloch states of the left electrode are unable to go through the right electrode at a positive bias voltage, because there is no transmission channel to receive them. So, the forward current in both spin channels is zero at the positive bias voltage range. However, when the negative bias voltage is applied to the device, the spin-up conduction bands of the left electrode cross the Fermi level, and thus some transmission channels are generated.

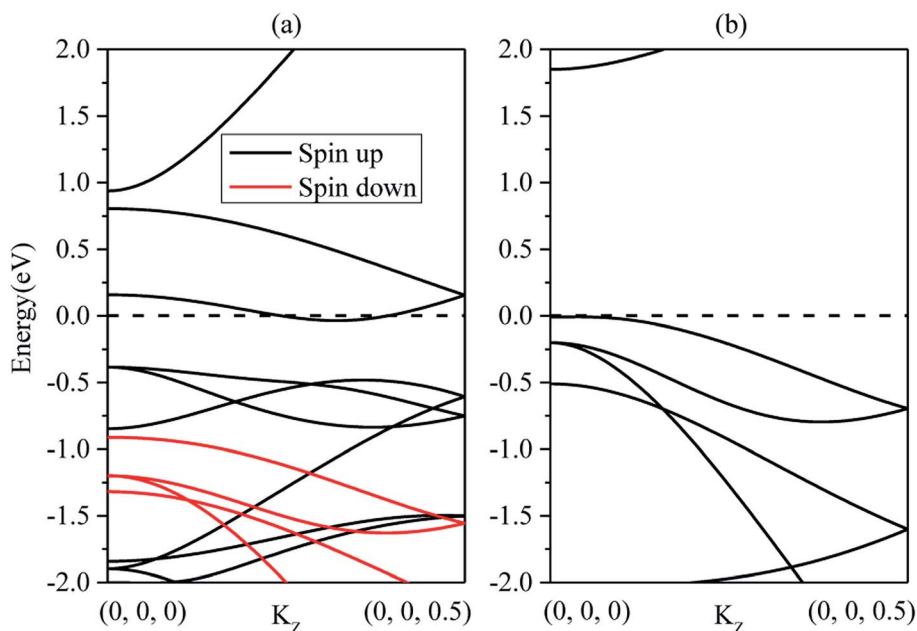


Fig. 3 Band structures along the (100) direction for the left electrode CrO_2 (a) and the right electrode TiO_2 (b). The dashed line means the Fermi level at zero eV.



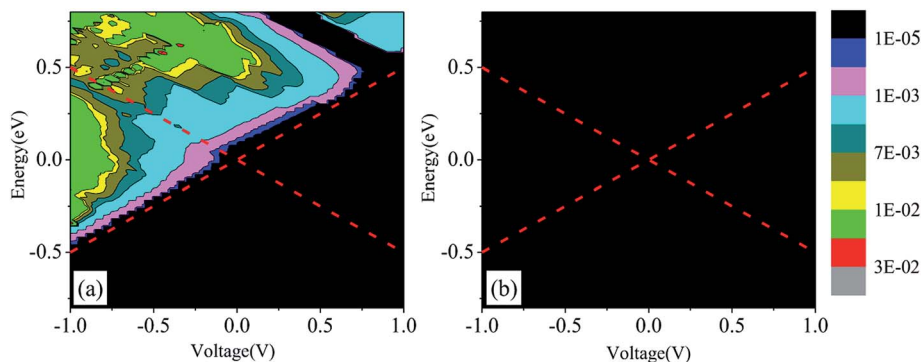


Fig. 4 The spin-dependent transmission spectra in the spin-up (a) and spin-down (b) channels for the $\text{CrO}_2/\text{TiO}_2$ (100) heterostructure.

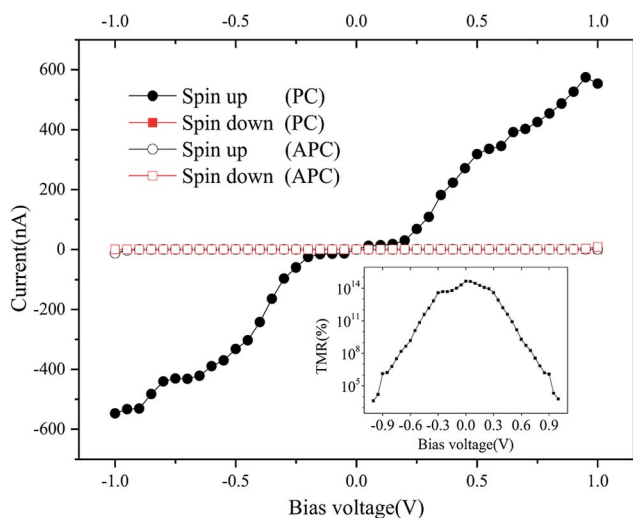


Fig. 5 The spin-dependent current-bias voltage curve of the $\text{CrO}_2/\text{TiO}_2/\text{CrO}_2$ (100) MTJ in the PC and the APC. The inset shows the TMR with the change of bias voltage.

Meanwhile, the Fermi level of the right electrode moves down, and in turn, the valence bands of right electrode cross the Fermi level, producing transmission channels. The well match of the spin-up resonance channels of two electrodes provides the transmission condition. This is similar to the open-circuit state. With the increase of the negative bias voltage, more and more bands cross the Fermi level, resulting in the increase of the transmission channels and the spin-up current, and thus the diode effect emerges in the spin-up channel. In the bias voltage range, the spin-down bands of CrO_2 are never able to cross the Fermi level due to the relatively wide band gaps above and below the Fermi level in the spin-down channel of the CrO_2 electrode. Therefore, there is no Bloch state in the spin-down channel and the spin-down current is zero, resulting in the spin filtering effect at the negative bias voltage.

To further understand the mechanism of the spin diode effect and the spin filtering effect, we show in Fig. 4 the calculated bias voltage-dependent transmission spectra. The red dotted lines represent the electrochemical potentials of the left/right electrode, and the area between lines denotes the bias

window. Note that the spin-polarized current can be obtained through the energy integral of transmission coefficients over the bias window. For the spin-up transmission spectra (Fig. 4(a)), there is no transmission coefficient in the positive bias window. So, the spin-up current is zero at the positive bias voltage. However, different phenomenon appears in the negative bias window, *i.e.*, with the increase of the negative bias voltage, the transmission coefficient value becomes more and more large, and the area of bias window becomes broader and broader. So, the spin-up current increases with increasing negative bias voltage, *i.e.*, the diode effect appears in the spin-up channel. However, for the spin-down transmission spectra (Fig. 4(b)), neither negative nor positive bias window is filled with transmission coefficient. So, the spin-down current is inhibited, leading to the spin filtering effect in the negative bias voltage range.

3.2. High tunnel magnetoresistance in the $\text{CrO}_2/\text{TiO}_2/\text{CrO}_2$ magnetic tunnel junction

We now calculate the spin transport properties of the $\text{CrO}_2/\text{TiO}_2/\text{CrO}_2$ (100) MTJ. The parallel magnetization configuration (PC) and the antiparallel magnetization configuration (APC) between the left and right CrO_2 electrodes are considered. Fig. 5 shows the calculated spin-dependent current with the change of bias voltage in the PC and APC. One can see clearly from Fig. 5 that the spin-down current in the PC and both spin-up and spin-down currents in the APC are almost zero in the bias voltage range considered. Only the spin-up current in the PC is considerable and it rapidly increases with increasing bias voltage. These distinctive I - V characteristics lead to the large TMR ratio, as shown in the inset of Fig. 5, it reaches $4.48 \times 10^{14}\%$ at zero bias voltage. Note that, there are usually three definitions of the TMR value: the “optimistic”, the “pessimistic” and the “normalized” TMR.⁴⁰ Here, we adopt the optimistic TMR = $[(I_P - I_{AP})/I_{AP}] \times 100\%$, where I_P (I_{AP}) is the total (spin-up plus spin-down) current for the MTJ in the PC (APC).⁴⁰ To explain the I - V characteristics and the large TMR ratio, we calculate the spin-dependent band structures of the CrO_2 electrode in the PC and APC (Fig. 6). For the PC, the magnetization directions of two electrodes are same, and thus the band structure of the left electrode (Fig. 6(a)) is identical to that of the



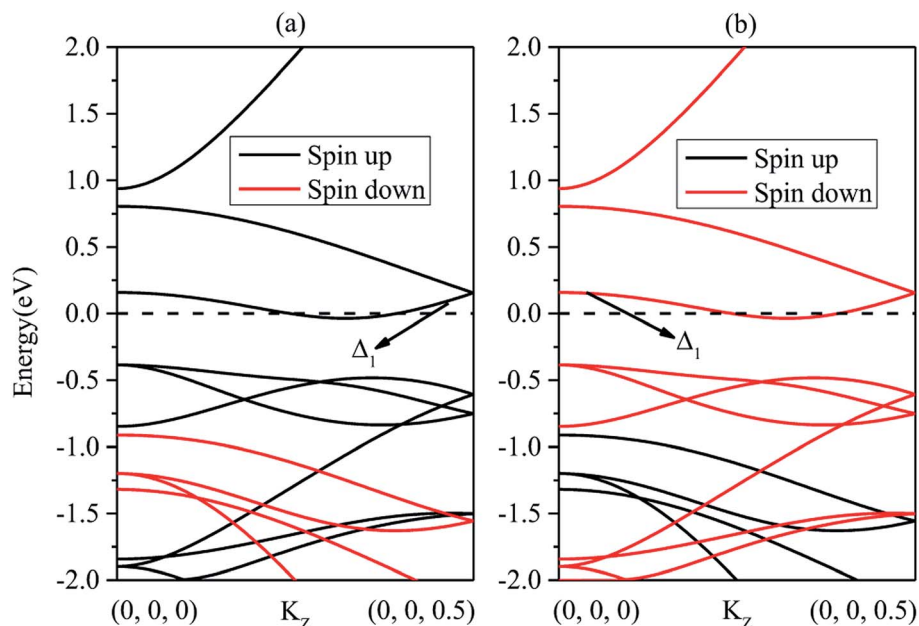


Fig. 6 Band structures along the (100) direction for the left and right electrodes of the $\text{CrO}_2/\text{TiO}_2/\text{CrO}_2$ (100) MTJ in the PC [(a) and (a)] and the APC [(a) and (b)].

right electrode (Fig. 6(a)). When a positive bias voltage is applied to the MTJ, the Fermi level of the left electrode moves down, and the Fermi level of the right electrode moves up. Due to the metallic properties in the spin-up direction, the Fermi levels of two electrodes always cross the bands and the transmission channels are generated in the spin-up channel of two electrodes simultaneously. So, the Bloch states started in the left electrode can be well received in the right electrode. With the increase of applied bias voltage, the spin-up current is increased. The same situation also appears in the case of the negative bias voltage. At the same time, we also note the semiconductor characteristic with a large energy gap in the spin-down channel. No matter what the bias voltage is applied in the PC, the large band gap always prevents the generation of transmission channels in the spin-down channel, and thus there is no spin-down current in the PC.

For the APC, the magnetization directions of two electrodes are completely opposite. That is, the spin-up bands and the spin-down bands are exchanged between the two electrodes. So, the band structures of the left and right electrodes correspond to Fig. 6(a) and (b), respectively. This spin-dependent inverse band structures between two electrodes and the large energy gap in one of the two spin channels result in the mismatch of the transmission channels no matter a positive or a negative bias voltage is applied, and in turn, both the spin-up and spin-down currents in the APC are suppressed. Therefore, the negligible current in the APC make the TMR ratio large. In order to explain the largest TMR value at the zero bias voltage (Fig. 5), we list in Table 1 the typical transport properties of the $\text{CrO}_2/\text{TiO}_2/\text{CrO}_2$ (100) MTJ. For the spin-up channel in the PC, the maximum transmission coefficient reaches 0.184, which is relatively larger in transport. It is to say, the incoming wave function of the left electrode Δ_1 band (Fig. 6) is slightly scattered

and the right electrode receives most of the incoming wave. For the spin-down channel in the PC, the transmission coefficient is much smaller than that in the spin-up channel, because the incoming wave function of Δ_1 band is nearly nonexistent. According to the definition of spin polarization, $SP = [(G_{\uparrow} - G_{\downarrow}) / (G_{\uparrow} + G_{\downarrow})] \times 100\%$, where G_{\uparrow} and G_{\downarrow} are the spin-up and spin-down conduction, respectively. The calculated spin polarization in the PC reaches 100%. This indicates that the CrO_2 electrode is a good spin injection source for the device. For the spin-up and spin-down channels in the APC, the maximum transmission coefficients are very small, because the incoming wave function of Δ_1 band only appears in one spin channel, and there is no corresponding Δ_1 symmetry state to receive them. Therefore, the incoming wave always decays along the transport direction, and both spin-up and spin-down conduction in the APC are very small. The great differences of T_{MAX} and G between the PC and APC at zero bias voltage result in the huge TMR ratio.

It should be pointed out that the TMR value is usually dependent on the thickness of the barrier, so we further calculate the TiO_2 layers dependence of TMR ratio, as shown in Fig. 7. It shows that the TMR value oscillates with the increase of

Table 1 Calculated spin transport properties of the $\text{CrO}_2/\text{TiO}_2/\text{CrO}_2$ (100) MTJ in the parallel magnetization configuration (PC) and the antiparallel magnetization configuration (APC). T_{MAX} is the largest transmission coefficient, G is the quantum conduction, and SP is the spin polarization at zero bias voltage for the MTJ

	T_{MAX}	G (siemens)	SP (%)
Spin-up in PC	1.84×10^{-1}	3.68×10^{-7}	100.00%
Spin-down in PC	2.03×10^{-16}	1.95×10^{-22}	
Spin-up in APC	4.04×10^{-14}	8.22×10^{-20}	99.99%
Spin-down in APC	3.67×10^{-18}	4.72×10^{-24}	



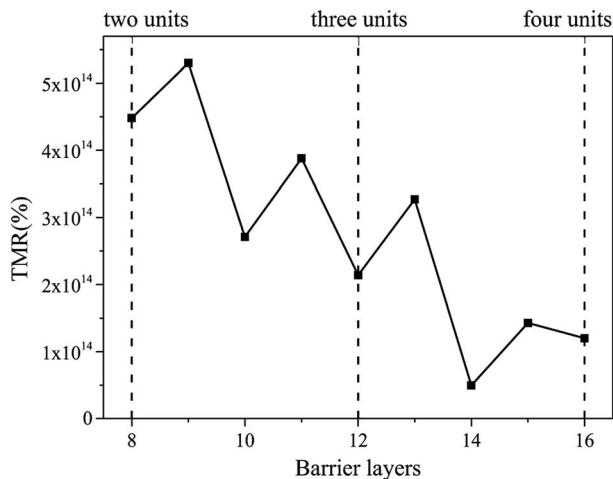


Fig. 7 The TiO₂ barrier thickness dependence of the TMR ratio in the CrO₂/TiO₂/CrO₂ (100) MTJ. The three dashed lines represent the thickness of two, three and four TiO₂ units, respectively.

the barrier thickness, but it still reaches $\sim 10^{14}\%$ when the thickness of the barrier is increased to three or four TiO₂ units. According to the Julliere model, TMR ratio is determined by spin polarization of both electrodes and irrelevant to barrier thickness.⁴¹ The TMR oscillatory indicates that the coherency of electron wave functions is conserved across the barrier, and TiO₂ plays a selective filtration role in transport mechanism.

Finally, we use the semiconductor theory to explain the current change with bias voltage in different magnetization configurations of the CrO₂/TiO₂/CrO₂ (100) MTJ. Fig. 8 indicates the calculated spin-dependent device density of states (DDOS). When the applied voltage is zero in the PC, the Fermi levels of

left and right electrodes are located at the same energy level, as shown in Fig. 8(a) and (b). It is found that the device is a typical metal–semiconductor–metal (MSM)⁴² structure in the spin-up channel, and the apparent metal induced gap states (MIGS) are formed at the region of TiO₂ due to the Fermi level pinning of semiconductor and metal.⁴³ During the pinning process, the Schottky barriers appear on the two metal–semiconductor interfaces. Under a positive bias voltage such as 0.5 V [Fig. 8(c)], the Fermi level of the left electrode shifts down, leading to the decrease of the barrier height around the left interface of the device. A lot of holes coming from the left electrode begin to inject into the TiO₂ intrinsic semiconductor. The rising Fermi level of the right electrode makes electrons inject into TiO₂ barrier from right to left. TiO₂ stores a lot of electrons and holes, and these carriers recombination causes TiO₂ resistivity to be lower. So, the higher the bias voltage between two electrodes, the bigger the passing spin-up current in the MSM structure. For the spin-down channel of the PC (Fig. 8(b) and (d)), the device is made of three wide band gap semiconductors. There is no carrier within bias window under a positive bias voltage. So, the high insulation resistance device generates negligible current. Fig. 8(e)–(h) are the spin-dependent DDOS in the APC under the bias voltages of zero and 0.5 V. In both spin-up and spin-down states, the devices are composed of the insulator–semiconductor–metal structure or the metal–semiconductor–insulator structure, which are similar to the metal–insulator–semiconductor (MIS) structure.⁴⁴ MIS plays the role of capacitor in the circuit and the electric conductive performance is poor, because there is no charge in the insulator region. So, the currents at positive bias voltage in the APC are very small and negligible, and this similar phenomenon is also found at the negative bias voltage in the APC (not shown here).

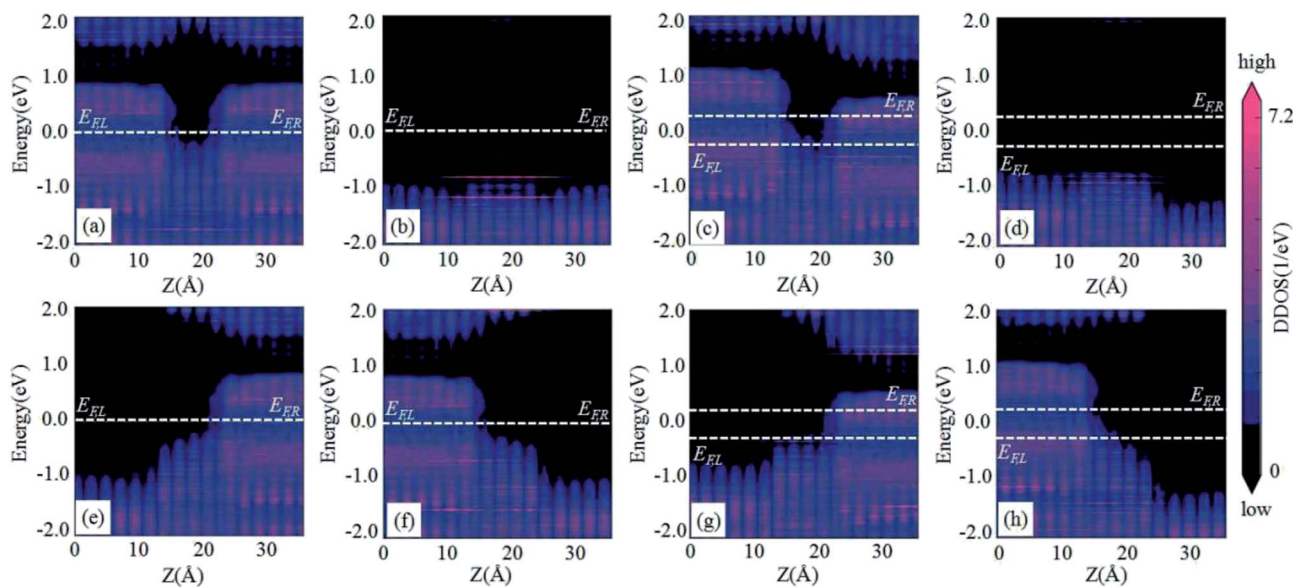


Fig. 8 The spin-dependent device density of states (DDOS) for the CrO₂/TiO₂/CrO₂ (100) MTJ at the bias voltages of zero V in the PC [(a) and (b)], 0.5 V in the PC [(c) and (d)], zero V in the APC [(e) and (f)] and 0.5 V in the APC [(g) and (h)]. [(a), (c), (e) and (g)] and [(b), (d), (f) and (h)] represent the spin-up and spin-down channels, respectively.



4. Conclusion

Half-metallic CrO₂ with 100% spin polarization make it meaningful to study the spin transport properties of the spintronic devices based on the CrO₂ electrode. Motivated by the experimental growth of the CrO₂ (100) films on TiO₂ (100) substrate, we construct the spintronic devices of the CrO₂/TiO₂ (100) heterostructure and the CrO₂/TiO₂/CrO₂ (100) MTJ. By using the first-principles calculations combined with the nonequilibrium Green's function, we predict the excellent spin diode and spin filtering effects in the heterostructure as well as the high TMR ratio in the MTJ, which indicate the potential spintronic applications of CrO₂. We also discuss the formation mechanism of these perfect spin transport properties from the calculated spin-dependent electrode band structures, the transmission spectra and the device density of states.

Conflicts of interest

There are no conflicts to declare.

Acknowledgements

This work was supported by the National Natural Science Foundation of China under Grant No. 11474113 and No. 11504278.

References

- 1 A. Hirohata and K. Takanashi, *J. Phys. D: Appl. Phys.*, 2014, **47**, 193001.
- 2 G. Schmidt, D. Ferrand, L. W. Molenkamp, A. T. Filip and B. J. van Wees, *Phys. Rev. B: Condens. Matter Mater. Phys.*, 2000, **62**, R4790–R4793.
- 3 R. A. de Groot, F. M. Mueller, P. G. V. Engen and K. H. J. Buschow, *Phys. Rev. Lett.*, 1983, **50**, 2024–2027.
- 4 H. C. Kandpal, G. H. Gerhard and C. Felser, *J. Phys. D: Appl. Phys.*, 2007, **40**, 1507–1523.
- 5 X. Wu, J. Han, Y. Feng, G. Li, C. Wang, G. Ding and G. Gao, *RSC Adv.*, 2017, **7**, 44499–44504.
- 6 J. He, P. Lyu and P. Nachtigall, *J. Mater. Chem. C*, 2016, **4**, 11143–11149.
- 7 R. Hu, Z. H. Zhang and Z. Q. Fan, *Phys. Chem. Chem. Phys.*, 2017, **19**, 20137–20146.
- 8 M. M. Monshi, S. M. Aghaei and I. Calizo, *RSC Adv.*, 2016, **7**, 18900–18908.
- 9 K. Schwarz, *J. Phys. F: Met. Phys.*, 1986, **16**, L211.
- 10 Y. Ji, G. J. Strijkers, F. Y. Yang, C. L. Chien, J. M. Byers, A. Anguelouch, G. Xiao and A. Gupta, *Phys. Rev. Lett.*, 2001, **86**, 5585–5588.
- 11 A. Anguelouch, A. Gupta, G. Xiao, D. W. Abraham, Y. Ji, S. Ingvarsson and C. L. Chien, *Phys. Rev. B: Condens. Matter Mater. Phys.*, 2001, **64**, 180408(R).
- 12 T. J. Swoboda, P. Arthur, N. L. Cox, J. N. Ingraham, A. L. Oppergard and M. S. Sadler, *J. Appl. Phys.*, 1961, **32**, 374S–375S.
- 13 D. O. Scanlon, C. W. Dunnill, J. Buckeridge, S. A. Shevlin, A. J. Logsdail, S. M. Woodley, C. R. Catlow, M. J. Powell, R. G. Palgrave, I. P. Parkin, G. W. Watson, T. W. Keal, P. Sherwood, A. Walsh and A. A. Sokol, *Nat. Mater.*, 2013, **12**, 798–801.
- 14 L. W. Fringer and R. M. Hazen, *J. Appl. Phys.*, 1980, **51**, 5362.
- 15 R. Cheng, B. Xu, C. N. Borca, A. Sokolov, C. S. Yang, L. Yuan, S. H. Liou, B. Doudin and P. A. Dowben, *Appl. Phys. Lett.*, 2001, **79**, 3122.
- 16 J. Dho, D.-H. Kim, D. Kwon and B. G. Kim, *J. Appl. Phys.*, 2008, **104**, 063528.
- 17 H. Fujiwara, M. Sunagawa, K. Terashima, T. Kittaka, T. Wakita, Y. Muraoka and T. Yokoya, *Appl. Phys. Lett.*, 2015, **106**, 202404.
- 18 P. B. Visscher, P. R. LeClair and A. Gupta, *Appl. Phys. Lett.*, 2013, **102**, 162410.
- 19 K. B. Chetry, M. Pathak, P. LeClair and A. Gupta, *J. Appl. Phys.*, 2009, **105**, 083925.
- 20 M. Rabe, J. Pommer, K. Samm, B. Özyilmaz, C. König, M. Fraune, U. Rüdiger, G. Güntherodt, S. Senz and D. Hesse, *J. Phys.: Condens. Matter*, 2002, **14**, 7.
- 21 S. Meena and S. Choudhary, *Phys. Chem. Chem. Phys.*, 2017, **19**, 17765–17772.
- 22 S. Meena and S. Choudhary, *Phys. Lett. A*, 2017, **381**, 3431–3439.
- 23 S. Meena and S. Choudhary, *AIP Adv.*, 2017, **7**, 125008.
- 24 S. Meena and S. Choudhary, *Mater. Chem. Phys.*, 2018, **217**, 175–181.
- 25 A. K. Singh, S. Choudhary and S. Meena, *J. Supercond. Novel Magn.*, 2018, **31**, 2753–2758.
- 26 T. Leo, C. Kaiser, H. Yang, S. S. P. Parkin, M. Sperlich, G. Güntherodt and D. J. Smith, *Appl. Phys. Lett.*, 2007, **91**, 252506.
- 27 V. Garcia, M. Bibes, A. Barthélémy, M. Bowen, E. Jacquet, J. P. Contour and A. Fert, *Phys. Rev. B: Condens. Matter Mater. Phys.*, 2004, **69**, 052403.
- 28 K. M. Kim, B. J. Choi, M. H. Lee, G. H. Kim, S. J. Song, J. Y. Seok, J. H. Yoon, S. Han and C. S. Hwang, *Nanotechnology*, 2011, **22**, 254010.
- 29 M. Bibes, M. Bowen, A. Barthélémy, A. Anane, K. Bouzehouane, C. Carrétéro, E. Jacquet, J. P. Contour and O. Durand, *Appl. Phys. Lett.*, 2003, **82**, 3269–3271.
- 30 H. Mahmoudi, T. Windbacher, V. Sverdlov and S. Selberherr, *21st International Conference "MIXDES 2014"*, Lublin, Poland, 2014, June 19–21, pp. 58–61.
- 31 M. S. Anwar and J. Aarts, *Phys. Rev. B: Condens. Matter Mater. Phys.*, 2013, **88**, 085123.
- 32 J. K. Burdett, T. Hughbanks, G. J. Miller, J. W. Richardson Jr and J. V. Smith, *J. Am. Chem. Soc.*, 1987, **109**, 3639–3646.
- 33 J. Taylor, H. Guo and J. Wang, *Phys. Rev. B: Condens. Matter Mater. Phys.*, 2001, **63**, 245407.
- 34 M. Brandbyge, J.-L. Mozos, P. Ordejón, J. Taylor and K. Stokbro, *Phys. Rev. B: Condens. Matter Mater. Phys.*, 2002, **65**, 165401.
- 35 J. P. Perdew, K. Burke and M. Ernzerhof, *Phys. Rev. Lett.*, 1996, **77**, 3865.
- 36 G. Y. Gao and K. L. Yao, *Appl. Phys. Lett.*, 2014, **105**, 182405.



Paper

- 37 J. Li, G. Gao, Y. Min and K. Yao, *Phys. Chem. Chem. Phys.*, 2016, **18**, 28018–28023.
- 38 Z. Zhu, Z. H. Zhang, D. Wang, X. Q. Deng, Z. Q. Fan and G. P. Tang, *J. Mater. Chem. C*, 2015, **3**, 9657–9663.
- 39 J. Zeng and K. Q. Chen, *J. Mater. Chem. C*, 2015, **3**, 5697–5702.
- 40 X. Feng, O. Bengone, M. Alouani, I. Rungger and S. Sanvito, *Phys. Rev. B: Condens. Matter Mater. Phys.*, 2009, **79**, 214432.
- 41 M. Julliere, *Phys. Lett.*, 1975, **54A**, 225–226.
- 42 S. M. Sze, D. J. Coleman and A. Loya, *Solid-State Electron.*, 1971, **14**, 1209–1218.
- 43 V. Heine, *Phys. Rev.*, 1965, **138**, A1689.
- 44 P. Cova, A. Singh and R. A. Masut, *J. Appl. Phys.*, 1997, **82**, 5217.

